Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10799900	WAIGHT ET AL.
Examiner	Art Unit
Pablo N Tran	2618

SEARCHED							
Class	Subclass	Date	Examiner				
455	333, 323, 326, 313, 332, 286-290, 293	8/22/10	PT				
333	186, 175	8/22/10	PT				
330	175	8/22/10	PT				

SEARCH NOTES		
Search Notes	Date	Examiner
East/West	8/22/10	PT

INTERFERENCE SEARCH					
Class	Subclass	Date	Examine		

	/Pablo N Tran/ Primary Examiner.Art Unit 2618
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